

領先創新•超越自我

2019 Synopsys ARC盃電子設計競賽







Electronic Component Defect Detection

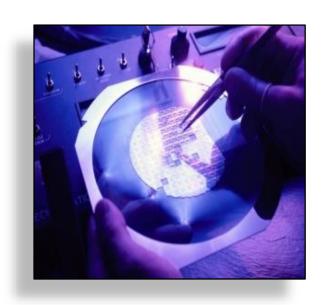
電子元件的瑕疵檢測

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- 項目概述
- 難點與創新
- 設計實現
- 測試結果
- 總結展望

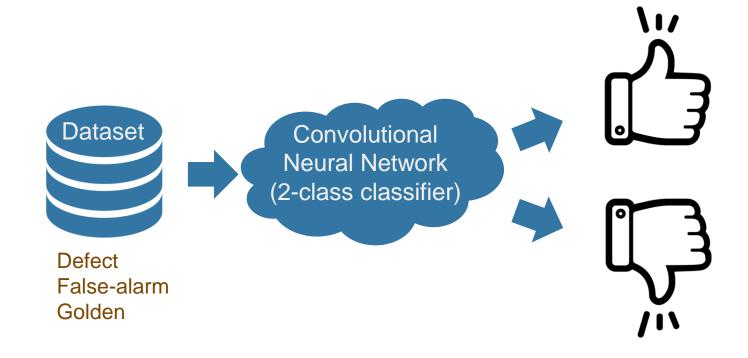


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Introduction

- Application
 - Highly accurately classify electronic components into good product and defective product
 - -Small convolutional neural network model can be run on IOT Development Kit



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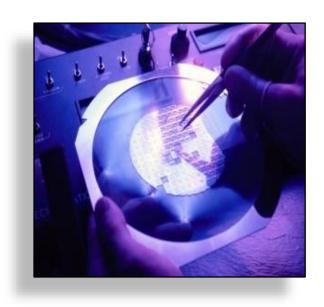


Challenge and Feature

- Challenge
 - -Small amount of data
 - Imbalanced data set
- Feature
 - Classified by machine, replacing human resource
 - Small amount of parameter
 - High accuracy

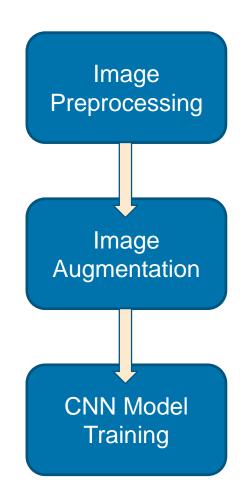


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Implementation

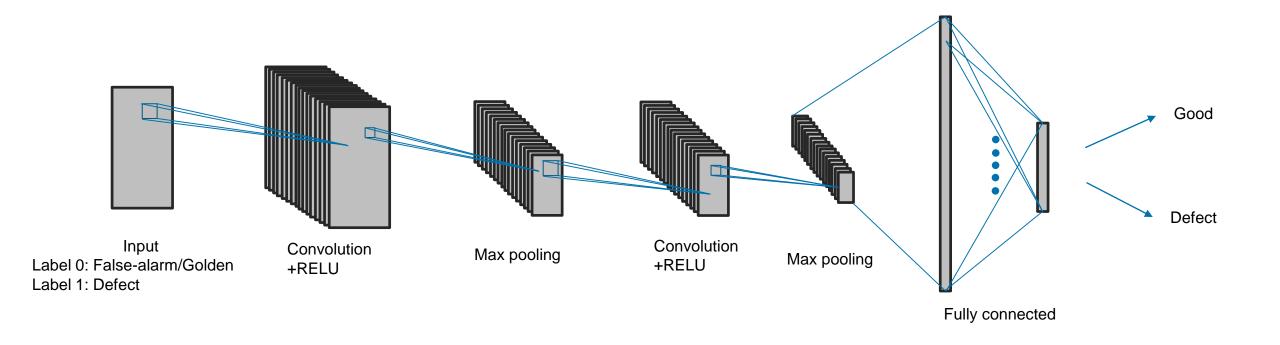
- Image preprocessing
 - Orientation rotation
 - -Resizing (40*20)
 - Gray scale (1 color channel)
- Image augmentation
 - Random rotation
 - Add noise
 - Flipping





Implementation

Convolutional neural network

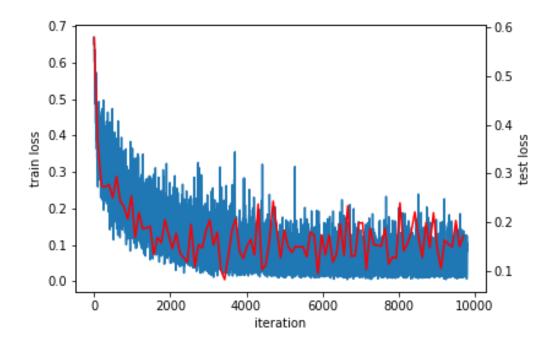




Training Result

• Training time: 48.2s

• Training accuracy: 98.4%



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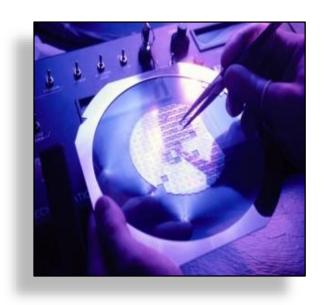
Result

• Accuracy: 82.4%

• Inference time: 8ms/per image



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Future Work and Conclusion

- Future work
 - Real-time defect detection
 - Detect all kinds of electronic component

- Conclusion
 - Small amount of parameter
 - Accuracy is about 82.4% on IOT Development Kit







Thank You